

EVALUATION KIT
AVAILABLE**MAXIM**

+5V Single-Supply, 2.2Msps, 14-Bit Self-Calibrating ADC

General Description

The MAX1201 is a 14-bit, monolithic, analog-to-digital converter (ADC) capable of conversion rates up to 2.2Msps. This integrated circuit, built on a CMOS process, uses a fully differential, pipelined architecture with digital error correction and a short self-calibration procedure that corrects for capacitor and gain mismatches and ensures 14-bit linearity at full sample rates. An on-chip track-and-hold (T/H) maintains superb dynamic performance up to the Nyquist frequency. The MAX1201 operates from a single +5V supply.

The fully differential inputs allow an input swing of $\pm V_{REF}$. A single-ended input is also possible using two operational amplifiers. The reference is also differential with the positive reference (RFPF) typically connected to +4.096V and the negative reference (RFNF) tied to analog ground. Additional sensing pins (RFPS, RFNS) are provided to compensate for any resistive divider action that may occur due to finite internal and external resistances.

The power dissipation is typically only 269mW at +5V and a sampling rate of 2.2Msps. The device employs a CMOS compatible, 14-bit parallel, two's complement output data format. The MAX1201 is available in a 44-pin MQFP package and is specified over the commercial temperature (0°C to +70°C) and extended (-40°C to +85°C) temperature ranges.

Applications

- xDSL
- Instrumentation
- Medical Imaging
- Scanners
- IR Imaging
- Spectrum Analysis

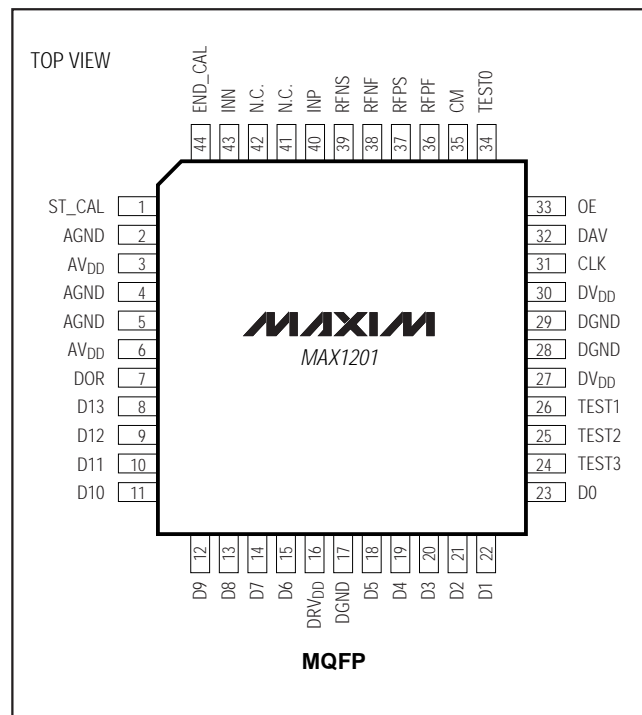
Features

- ◆ Monolithic 14-Bit, 2.2Msps ADC
- ◆ Signal-to-Noise Ratio of 83dB
- ◆ Spurious-Free Dynamic Range of 91dB
- ◆ Differential Nonlinearity Error: $\pm 0.3\text{LSB}$
- ◆ Integral Nonlinearity Error: $\pm 1.2\text{LSB}$
- ◆ Single +5V Analog Supply, +3V Digital Supply
- ◆ Low Power Dissipation: 269mW
- ◆ On-Demand Self-Calibration
- ◆ Three-State, Two's Complement Output Data

Ordering Information

| PART | TEMP. RANGE | PIN-PACKAGE |
|------------|----------------|-------------|
| MAX1201CMH | 0°C to +70°C | 44 MQFP |
| MAX1201EMH | -40°C to +85°C | 44 MQFP |

Pin Configuration

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MAX1201

+5V Single-Supply, 2.2Msps, 14-Bit Self-Calibrating ADC

ABSOLUTE MAXIMUM RATINGS

| | | | |
|---------------------------------|--|---|-----------------|
| AV _{DD} to AGND, DGND | +7V | Continuous Power Dissipation (T _A = +70°C) | |
| DV _{DD} to DGND, AGND | +7V | 44-Pin MQFP (derate 11.11mW/°C above +70°C) | 889mW |
| DRV _{DD} to DGND, AGND | +7V | Operating Temperature Ranges (T _A) | |
| INP, INN, RFPF, RFPS, | | MAX1201CMH | 0°C to +70°C |
| RFNF, RFNS, CLK, CM | (AGND - 0.3V) to (AV _{DD} + 0.3V) | MAX1201EMH | -40°C to +85°C |
| Digital Inputs to DGND | -0.3V to (DV _{DD} + 0.3V) | Storage Temperature Range | -65°C to +160°C |
| Digital Output (DAV) to DGND | -0.3V to (DRV _{DD} + 0.3V) | Lead Temperature (soldering, 10sec) | +300°C |
| Other Digital Outputs to DGND | -0.3V to (DRV _{DD} + 0.3V) | | |

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

ELECTRICAL CHARACTERISTICS

(AV_{DD} = +5V ±5%, DV_{DD} = DRV_{DD} = +3.3V, V_{RFPS} = +4.096V, V_{RFNS} = AGND, V_{CM} = +2.048, V_{IN} = -0.5dBFS, f_{CLK} = 4.5056MHz, digital output load ≤ 20pF, T_A = T_{MIN} to T_{MAX} = 0°C to +70°C, unless otherwise noted. Typical values are at T_A = +25°C.) (Note 1)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|--|---------------------|---|--------|--------|------|----------------------------|
| Input Voltage Range (Notes 2, 3) | V _{IN} | Single-ended | | 4.096 | 4.5 | V |
| | | Differential | | ±4.096 | ±4.5 | |
| Input Resistance (Note 4) | R _I | | | 25 | | kΩ |
| Input Capacitance | C _I | Per side in Track Mode | | 21 | | pF |
| Reference Voltage (Note 3) | V _{REF} | | | 4.096 | 4.5 | V |
| Reference Input Resistance | | | 700 | 1000 | | Ω |
| Resolution (no missing codes; Note 5) | RES | After calibration, guaranteed | 14 | | | Bits |
| Integral Nonlinearity | INL | | | ±1.2 | | LSB |
| Differential Nonlinearity | DNL | | -1 | ±0.3 | +1 | LSB |
| Offset Error | | | -0.1 | ±0.004 | +0.1 | %FSR |
| Gain Error | | | -5 | -1.7 | +5 | %FSR |
| Input-Referred Noise | | f _{CLK} | | 75 | | μV _{RMS} |
| Maximum Sampling Rate | f _{SAMPLE} | f _{SAMPLE} = f _{CLK} /2 | 2.2528 | | | Msps |
| Conversion Time (Pipeline Delay/Latency) | | | | 4 | | f _{SAMPLE} Cycles |
| Acquisition Time | t _{ACO} | To full-scale step (0.006%) | | 100 | | ns |
| Overvoltage Recovery Time | t _{OVR} | | | 410 | | ns |
| Aperture Delay | t _{AD} | | | 3 | | ns |
| Full-Power Bandwidth | | | | 3.3 | | MHz |
| Small-Signal Bandwidth | | | | 78 | | MHz |

+5V Single-Supply, 2.2Msps, 14-Bit Self-Calibrating ADC

MAX1201

ELECTRICAL CHARACTERISTICS (continued)

(AVDD = +5V ±5%, DVDD = DRVDD = +3.3V, VRFPS = +4.096V, VRFNS = AGND, VCM = +2.048, VIN = -0.5dBFS, fCLK = 4.5056MHz, digital output load ≤ 20pF, TA = TMIN to TMAX = 0°C to +70°C, unless otherwise noted. Typical values are at TA = +25°C.) (Note 1)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|--|----------|------------------------------|------|-----|-------|-------|
| Signal-to-Noise Ratio (Note 5) | SNR | fIN = 100.1kHz | 78 | 83 | | dB |
| | | fIN = 502.7kHz | | 82 | | |
| | | fIN = 1.0021MHz | | 81 | | |
| Spurious-Free Dynamic Range (Note 5) | SFDR | fIN = 100.1kHz | 84 | 91 | | dB |
| | | fIN = 502.7kHz | | 89 | | |
| | | fIN = 1.0021MHz | | 86 | | |
| Total Harmonic Distortion (Note 6) | THD | fIN = 100.1kHz | | -88 | -80 | dB |
| | | fIN = 502.7kHz | | -85 | | |
| | | fIN = 1.0021MHz | | -83 | | |
| Signal-to-Noise Ratio + Distortion (Note 5) | SINAD | fIN = 100.1kHz | 77 | 82 | | dB |
| | | fIN = 502.7kHz | | 79 | | |
| | | fIN = 1.0021MHz | | 78 | | |
| POWER REQUIREMENTS | | | | | | |
| Analog Supply Voltage | AVDD | | 4.75 | 5 | 5.25 | V |
| Analog Supply Current | I(AVDD) | | | 53 | 75 | mA |
| Digital Supply Voltage | DVDD | | 3 | | 5.25 | V |
| Digital Supply Current | I(DVDD) | | | 1 | 2 | mA |
| Output Drive Supply Voltage | DRVDD | | 3 | | DRVDD | V |
| Output Drive Supply Current | I(DRVDD) | 10pF loads on D0-D13 and DAV | | 0.3 | 1 | mA |
| Power Dissipation | PDSS | | | 269 | 380 | mW |
| Warm-Up Time | | | | 0.1 | | sec |
| Power-Supply Rejection Ratio | PSRR | Offset | 55 | | | dB |
| | | Gain | 55 | | | |

TIMING CHARACTERISTICS

(AVDD = +5V, DVDD = DRVDD = +3.3V, fCLK = 4.5056MHz, TA = TMIN to TMAX = 0°C to +70°C, unless otherwise noted. Typical values are at TA = +25°C.) (Note 1)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|------------------------|--------|---------------|-----|-----------|-----|-------------|
| Conversion Time | tCONV | | | 4/fSAMPLE | | ns |
| Clock Period | tCLK | | | 227 | | ns |
| Clock High Time | tCH | | 85 | 113.5 | 137 | ns |
| Clock Low Time | tCL | | 85 | 113.5 | 137 | ns |
| Output Delay | tOD | | | 70 | 150 | ns |
| DAV Pulse Width | tDAV | | | 1/fCLK | | ns |
| CLK-to-DAV Rising Edge | ts | | | 65 | 145 | ns |
| Data Access Time | tAC | CL = 20pF | | 16 | 75 | ns |
| Bus Relinquish Time | tREL | | | 16 | 75 | ns |
| Calibration Time | tCAL | ST_CAL = DVDD | | 17,400 | | fCLK cycles |

+5V Single-Supply, 2.2Msps, 14-Bit Self-Calibrating ADC

MAX1201

DIGITAL INPUT AND OUTPUT CHARACTERISTICS

($V_{DD} = +5V$, $DV_{DD} = DRV_{DD} = +3.3V$, $T_A = T_{MIN}$ to T_{MAX} , unless otherwise noted. Typical values are at $T_A = +25^\circ C$.)

| PARAMETER | SYMBOL | CONDITIONS | MIN | TYP | MAX | UNITS |
|--------------------------------|---------------|-----------------------------|-----------------|------------------|----------|---------|
| Input Low Voltage | V_{IL} | | | | 0.8 | V |
| Input High Voltage | V_{IH} | | $DV_{DD} - 0.8$ | | | V |
| Input Capacitance | | | | 4.0 | | pF |
| CLK Input Low Voltage | CLK_{VIL} | | | | 0.8 | V |
| CLK Input High Voltage | CLK_{VIH} | | $AV_{DD} - 0.8$ | | | V |
| CLK Input Current | I_{CLK} | $V_{IN_} = 0$ or DV_{DD} | | ± 1 | ± 10 | μA |
| CLK Input Capacitance | C_{CLK} | | | 9 | | pF |
| Digital Input Current | I_{IN} | $V_{IN_} = 0$ | | ± 0.1 | ± 10 | μA |
| | | $V_{IN_} = DV_{DD}$ | | ± 0.1 | ± 10 | |
| Output Low Voltage | V_{OL} | $I_{SINK} = 1.6mA$ | | 70 | 400 | mV |
| Output High Voltage | V_{OH} | $I_{SOURCE} = 200\mu A$ | $DV_{DD} - 0.4$ | $DV_{DD} - 0.03$ | | V |
| Three-State Leakage Current | $I_{LEAKAGE}$ | | | ± 0.1 | ± 10 | μA |
| Three-State Output Capacitance | C_{OUT} | | | 3.5 | | pF |

Note 1: Reference inputs driven by operational amplifiers for Kelvin-sensed operation.

Note 2: For unipolar mode, the analog input voltage, V_{INP} , must be within 0V and V_{REF} . $V_{INN} = V_{REF} / 2$; where $V_{REF} = V_{RFPS} - V_{RFNS}$. For differential mode, the analog input voltages V_{INP} and V_{INN} must be within 0V and V_{REF} ; where $V_{REF} = V_{RFPS} - V_{RFNS}$. The common-mode voltage of the inputs INP and INN is $V_{REF} / 2$.

Note 3: Minimum and maximum parameters are not tested. Guaranteed by design.

Note 4: Input resistance varies inversely with sample rate.

Note 5: Calibration remains valid for temperature changes within $\pm 20^\circ C$ and power-supply variations $\pm 5\%$.

Note 6: All AC specifications are shown for the differential mode.

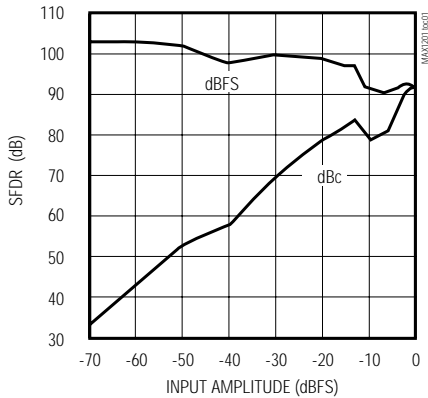
+5V Single-Supply, 2.2MSPS, 14-Bit Self-Calibrating ADC

MAX1201

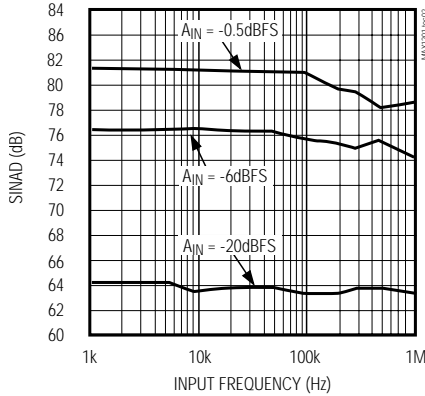
Typical Operating Characteristics

($V_{DD} = +5V$, $DV_{DD} = DRV_{DD} = +3.3V$, $V_{RFPS} = +4.096V$, $V_{RFNS} = AGND$, $f_{CLK} = 4.5056MHz$, differential input, $V_{CM} = +2.048V$, calibrated, $T_A = +25^\circ C$, unless otherwise noted.)

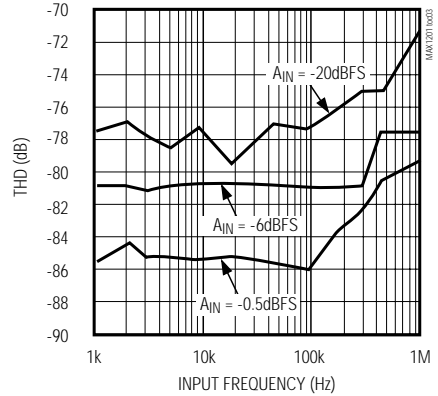
SINGLE-TONE SPURIOUS-FREE DYNAMIC RANGE vs. INPUT AMPLITUDE ($f_{IN} = 100.1kHz$)



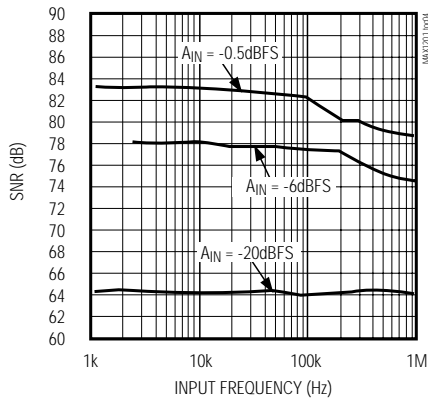
SIGNAL-TO-NOISE PLUS DISTORTION vs. INPUT FREQUENCY



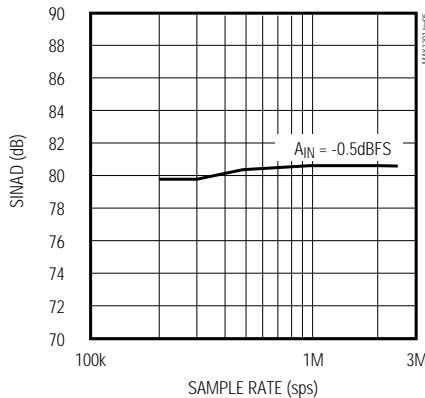
TOTAL HARMONIC DISTORTION vs. INPUT FREQUENCY



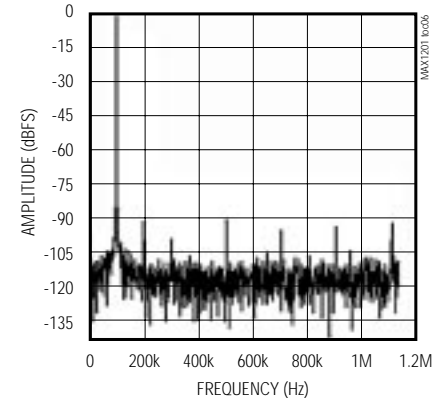
SIGNAL-TO-NOISE-RATIO vs. INPUT FREQUENCY



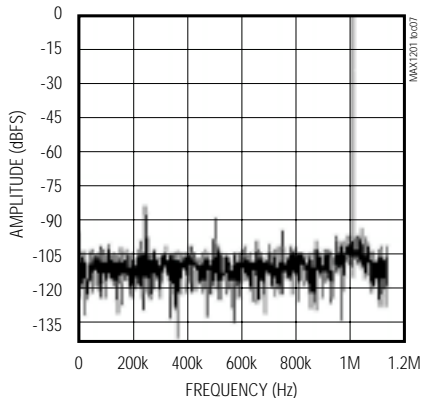
SIGNAL-TO-NOISE-RATIO PLUS DISTORTION vs. SAMPLE RATE ($f_{IN} = 100.1kHz$)



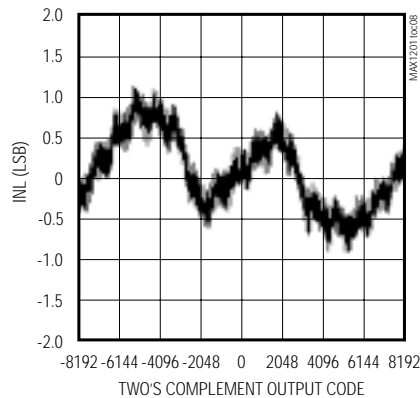
TYPICAL FFT, $f_{IN} = 100.1kHz$, 2048 VALUE RECORD



TYPICAL FFT, $f_{IN} = 1.0021MHz$, 2048 VALUE RECORD



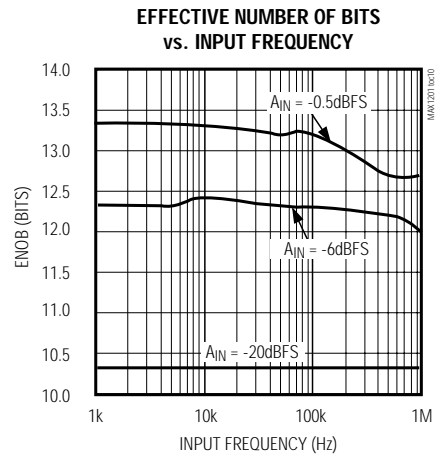
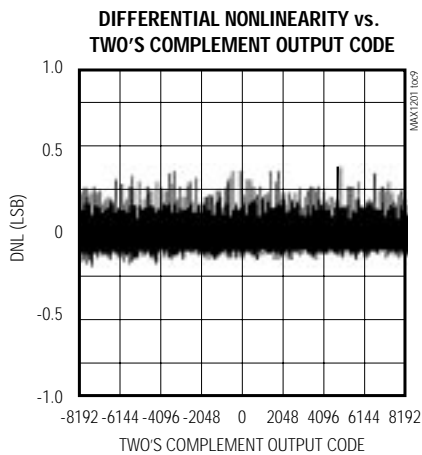
INTEGRAL NONLINEARITY vs. TWO'S COMPLEMENT OUTPUT CODE



+5V Single-Supply, 2.2Msps, 14-Bit Self-Calibrating ADC

Typical Operating Characteristics (continued)

($V_{DD} = +5V$, $DV_{DD} = DRV_{DD} = +3.3V$, $V_{RFPS} = +4.096V$, $V_{RFNS} = AGND$, $f_{CLK} = 4.5056MHz$, differential input, $V_{CM} = +2.048V$, calibrated, $T_A = +25^\circ C$, unless otherwise noted.)



Pin Description

| PIN | NAME | FUNCTION |
|---------|-------------------|---|
| 1 | ST_CAL | Digital Input to Start Calibration. ST_CAL = 0: Normal conversion mode. ST_CAL = 1: Start self-calibration. |
| 2, 4, 5 | AGND | Analog Ground |
| 3, 6 | AV _{DD} | Analog Power Supply, +5V ±5% |
| 7 | DOR | Data Out-of-Range Bit |
| 8 | D13 | Bit 13 (MSB) |
| 9 | D12 | Bit 12 |
| 10 | D11 | Bit 11 |
| 11 | D10 | Bit 10 |
| 12 | D9 | Bit 9 |
| 13 | D8 | Bit 8 |
| 14 | D7 | Bit 7 |
| 15 | D6 | Bit 6 |
| 16 | DRV _{DD} | Digital Power Supply for the Output Drivers. +3V to +5.25V, $DRV_{DD} \leq DV_{DD}$. |
| 17, 28 | DGND | Digital Ground |
| 18 | D5 | Bit 5 |
| 19 | D4 | Bit 4 |
| 20 | D3 | Bit 3 |

+5V Single-Supply, 2.2Msps, 14-Bit Self-Calibrating ADC

Pin Description (continued)

MAX1201

| PIN | NAME | FUNCTION |
|--------|------------------|---|
| 21 | D2 | Bit 2 |
| 22 | D1 | Bit 1 |
| 23 | D0 | Bit 0 (LSB) |
| 24 | TEST3 | Test Pin 3. Leave unconnected. |
| 25 | TEST2 | Test Pin 2. Leave unconnected. |
| 26 | TEST1 | Test Pin 1. Leave unconnected. |
| 27, 30 | DV _{DD} | Digital Power Supply, +3V to +5.25V. |
| 31 | CLK | Input Clock. Receives power from AV _{DD} to reduce jitter. |
| 32 | DAV | Data Valid Clock. Digital Output. This clock can be used to transfer the data to a memory or any other data-acquisition system. |
| 33 | OE | Output Enable: Digital Input. OE = 0: D0–D13 and DOR are high impedance. OE = 1: All bits are active. |
| 34 | TEST0 | Test Pin 0. Leave unconnected. |
| 35 | CM | Common-Mode Voltage. Analog Input. Drive midway between positive and negative reference voltages. |
| 36 | RFPF | Positive Reference Voltage. Force Input. |
| 37 | RFPS | Positive Reference Voltage. Sense Input. |
| 38 | RFNF | Negative Reference Voltage. Force Input. |
| 39 | RFNS | Negative Reference Voltage, Sense Input. |
| 40 | INP | Positive Input Voltage |
| 41, 42 | N.C. | Not Connected. No internal connection. |
| 43 | INN | Negative Input Voltage |
| 44 | END_CAL | Digital Output for End of Calibration. END_CAL = 0: Calibration in progress. END_CAL = 1: Normal conversion mode. |

+5V Single-Supply, 2.2Msps, 14-Bit Self-Calibrating ADC

Detailed Description

Converter Operation

The MAX1201 is a 14-bit, monolithic, analog-to-digital converter (ADC) capable of conversion rates up to 2.2Msps. It uses a multistage, fully differential, pipelined architecture with digital error correction and self-calibration to provide 90dB (typ) spurious-free dynamic range at a 2.2Msps sampling rate. Its signal-to-noise ratio, harmonic distortion, and intermodulation products are also consistent with 14-bit accuracy up to the Nyquist frequency. This makes the device suitable for applications such as xDSL, digital radio, instrumentation, and imaging.

Figure 1 shows the simplified, internal structure of the ADC. A switched-capacitor pipelined architecture is used to digitize the signal at a high throughput rate. The first four stages of the pipeline use a low resolution quantizer to approximate the input signal. The multiplying digital-to-analog converter (MDAC) stage is used to subtract the quantized analog signal from the input. The residue is then amplified with a fixed gain and passed on to the next stage. The accuracy of the converter is improved by a digital calibration algorithm which corrects for mismatches between the capacitors

in the switched capacitor MDAC. Note that the pipeline introduces latency of four sampling periods between the input being sampled and the output appearing at D13–D0. While the device can handle both single-ended or differential inputs (see *Requirements for Reference and Analog Signal Inputs*), the latter mode of operation will guarantee best THD and SFDR performance. The differential input provides the following advantages compared to a single-ended operation:

- Twice as much signal input span
- Common-mode noise immunity
- Virtual elimination of the even-order harmonics
- Less stringent requirements on the input signal processing amplifiers

Requirements for Reference and Analog Signal Inputs

Fully differential switched capacitor circuits (SC) are used for both the reference and analog inputs (Figure 2). This allows either single-ended or differential signals to be used in the reference and/or analog signal paths. The signal voltage on these pins (INP, INN, RFP_, RFN_) should neither exceed the analog supply rail, AVDD nor fall below ground.

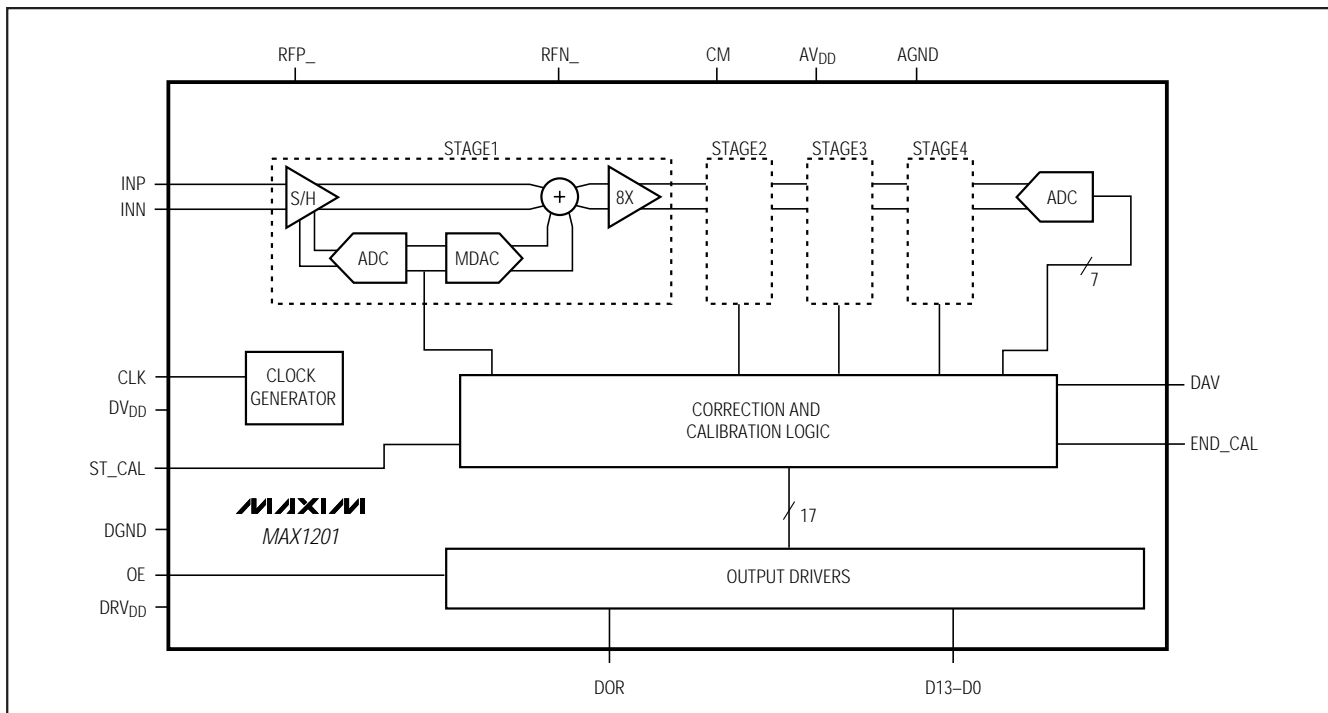


Figure 1. Internal Block Diagram

+5V Single-Supply, 2.2MSPS, 14-Bit Self-Calibrating ADC

MAX1201

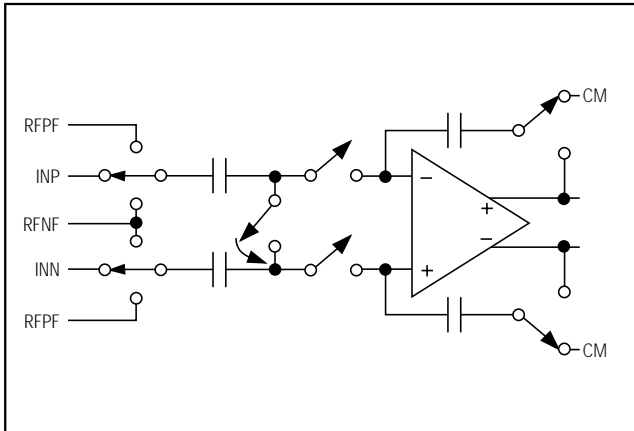


Figure 2. Simplified MDAC Architecture

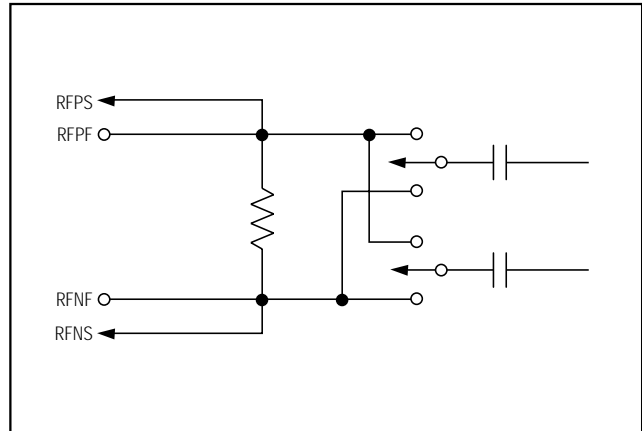


Figure 3. Equivalent Input at the Reference Pins. The sense pins should not draw any DC current.

Choice of Reference

It is important to choose a low-noise reference, such as the MAX6341, which can provide both excellent load regulation and low temperature drift. The equivalent input circuit for the reference pins is shown in Figure 3. Note that the reference pins drive approximately $1\text{k}\Omega$ of resistance on chip. They also drive a switched capacitor of 21pF . To meet the dynamic performance, the reference voltage is required to settle to 0.0015% within one clock cycle. Carefully choose an appropriate driving circuit (Figure 4). The capacitors at the reference pins (RFPF, RFNF) provide the dynamic charge required during each clock cycle, while the op amps ensure accuracy of the reference signals. These capacitors must have low dielectric-absorption characteristics, such as polystyrene or teflon capacitors.

The reference pins can be connected to either single-ended or differential voltages within the specified maximum levels. Typically, the positive reference pin (RFPF) would be driven to 4.096V , and the negative reference pin (RFNF) connected to analog ground. There are sense pins, RFPS and RFNS, which can be used with external amplifiers to compensate for any resistive drop on these lines, internal or external to the chip. Assure a correct reference voltage by using proper Kelvin connections at the sense pins.

Common-Mode Voltage

The switched capacitor circuit at the analog input allows signals between AGND and the analog power supply. Since the common-mode voltage has a strong influence on the performance of the ADC, the best results are obtained by choosing V_{CM} to be at half the difference between the reference voltages V_{RFP} and V_{RFN} . Achieve

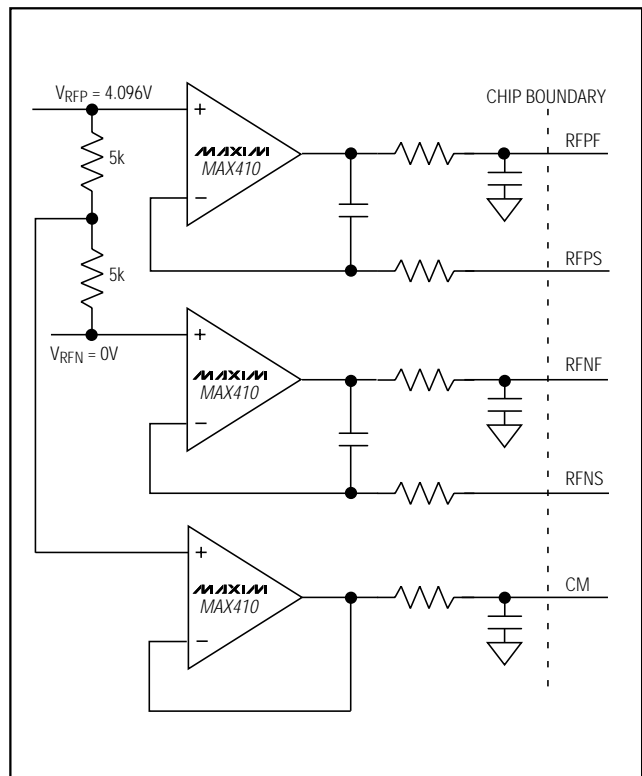


Figure 4. Drive Circuit for Reference Pins and Common-Mode Pin

this by using a resistive divider between the two reference potentials. Figure 4 shows the driving circuit for good dynamic performance.

+5V Single-Supply, 2.2Msps, 14-Bit Self-Calibrating ADC

Analog Signal Conditioning

For single-ended inputs, the negative analog input pin (INN) is tied to the common-mode voltage pin (CM), and the positive analog input pin (INP) is connected to the input signal. The common-mode voltage of INP must be equal to the common-mode input. To take full advantage of the ADC's superior AC performance up to Nyquist frequency, drive the chip with differential signals. While in communication systems the signals may inherently be available in differential mode, medical and/or other applications may only provide single-ended inputs. In this case, convert the single-ended signals into differential ones by using the circuit recommended in Figure 5. Use low-noise, wideband amplifiers, such as the MAX4108, to maintain the signal purity over the full-power bandwidth of the MAX1201. Lowpass or bandpass filters may be required to improve the signal-to-noise-and-distortion ratio of the incoming signal. For low-frequency signals (<100kHz), active filters may be used. For higher frequencies, passive filters are more convenient.

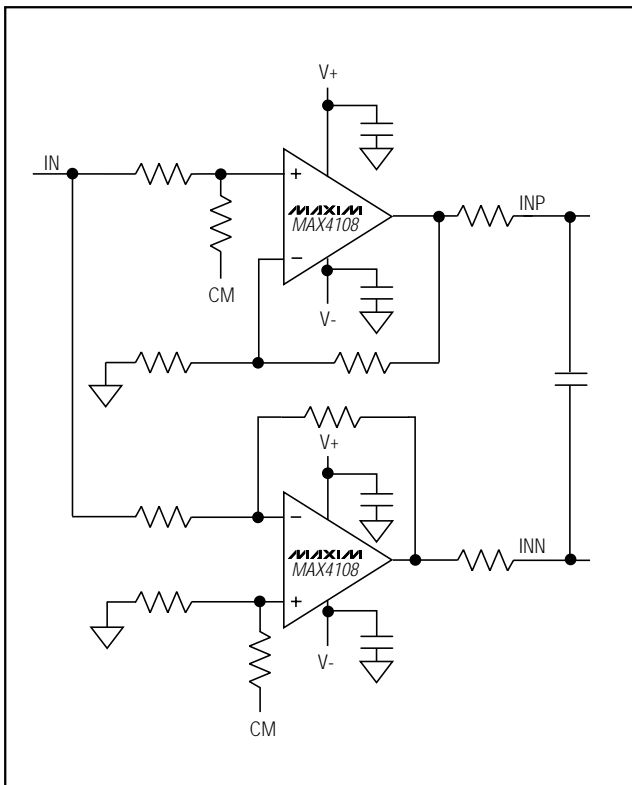


Figure 5. A simple circuit generates differential signals from a single-ended input referred to analog ground. The common-mode voltage at INP and INN is the same as CM.

Single-Ended to Differential Conversion Using Transformers

An alternative single-ended to differential-ended conversion method is a balun transformer such as the CTX03-13675 from Coiltronics. An important benefit of these transformers is their ability to level-shift a single-ended signal, referred to ground on the primary side, to optimum common-mode voltages on the secondary side. At frequencies below 20kHz, the transformer core begins to saturate, causing odd-order harmonics.

Clock Source Requirements

Pipelined ADCs typically need a 50% duty cycle clock. To avoid this constraint, the MAX1201 provides a divide-by-two circuit which relaxes this requirement. The clock generator should be chosen commensurate with the frequency range, amplitude and slew rate of the signal source. If the slew rate of the input signal is low, the jitter requirement on the clock is relaxed. However, if the slew rate is high, the clock jitter needs to be kept at a minimum. For a full-scale amplitude input sine wave, the maximum possible SNR due completely to clock jitter is given by

$$SNR_{MAX} = \frac{1}{2 \cdot \pi \cdot f_{IN} \cdot \sigma_{JITTER}}$$

For example, if f_{IN} is 1MHz and σ_{JITTER} is 10ps RMS, then the SNR limit due to jitter is approximately 84dB. Generating such a clock source requires a low-noise comparator and a low-phase noise signal generator. The clock circuit shown in Figure 6 is a possible solution.

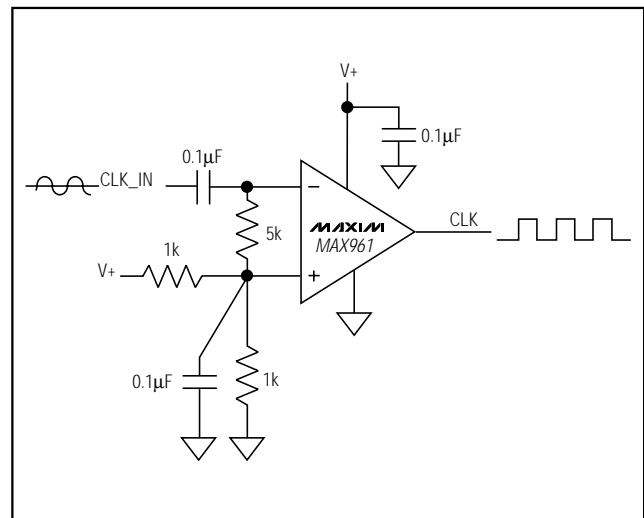


Figure 6. Clock Generation Circuit Using Low-Noise Comparator

+5V Single-Supply, 2.2MSPS, 14-Bit Self-Calibrating ADC

MAX1201

Calibration Procedure

Since the MAX1201 is based on a pipelined architecture, low-resolution quantizers (“coarse ADCs”) are used to approximate the input signal. MDACs of the same resolution are then used to reconstruct the input signal, which is subtracted from the input and the residue is amplified by the switched-capacitor gain stage. This residue is then passed on to the next stage. The accuracy of the MAX1201 is limited by the precision of the MDAC, which is strongly dependent on the matching of the capacitors used. The mismatch between the capacitors is determined and stored in an on-chip memory, which is later used during the conversion of the input signal.

During the calibration procedure, the clock must be running continuously. ST_CAL (start of calibration) is initiated by a positive pulse with a minimum width of four clock cycles but no longer than about 17,400 clock cycles (Figure 8).

The ST_CAL input may be asynchronous with the clock, since it is retimed internally. With ST_CAL activated, END_CAL goes low one or two clock cycles later and remains low until the calibration is complete. During this period, the reference voltages must be stable to less than 0.01%; otherwise, the calibration will be invalid. During calibration, the analog inputs INP and INN are not used; however, better performance is achieved if these inputs are static. Once END_CAL goes high (indicating that the calibration procedure is complete), the ADC is ready for conversion.

Once calibrated, the MAX1201 is insensitive to small changes ($\pm 5\%$) in power supply, voltage, or temperature. Following calibration, if the temperature changes more than $\pm 20^\circ\text{C}$, the device should be recalibrated to maintain optimum performance.

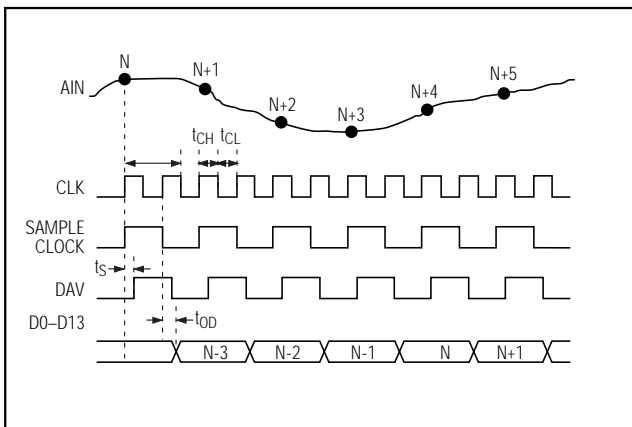


Figure 7. Main Timing Diagram

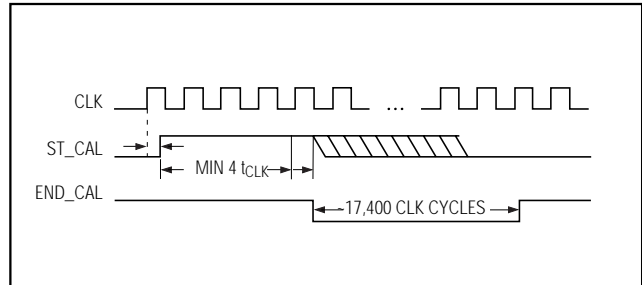


Figure 8. Timing for Start and End of Calibration

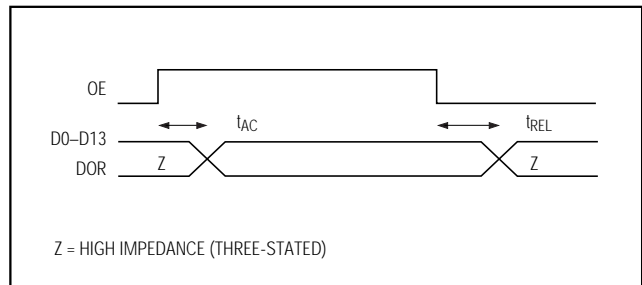


Figure 9. Timing for Bus Access and Bus Relinquish—Controlled by Output Enable (OE)

Two's Complement Output

The MAX1201 outputs data in two's complement format. Table 1 shows how to convert the various full-scale inputs into their two's complement output codes.

Applications Information

Signal-to-Noise Ratio (SNR)

For a waveform perfectly reconstructed from digital samples, the theoretical maximum SNR is the ratio of full-scale analog input (RMS value) to the RMS quantization error (residual error). The ideal, theoretical minimum analog-to-digital noise is caused by quantization error only and results directly from the ADC's resolution (N bits):

$$\text{SNR}_{(\text{MAX})} = (6.02 \cdot N + 1.76)\text{dB}$$

In reality, there are other noise sources besides quantization noise including thermal noise, reference noise, clock jitter, etc. Therefore, SNR is computed by taking the ratio of the RMS signal to the RMS noise which includes all spectral components minus the fundamental, the first nine harmonics, and the DC offset.

+5V Single-Supply, 2.2Msps, 14-Bit Self-Calibrating ADC

Table 1. Binary Output Codes

| SCALE | OFFSET BINARY | ONE'S COMPLEMENT | TWO'S COMPLEMENT |
|-------------|----------------|------------------|------------------|
| +FSR - 1LSB | 1111 1111 | 0111 1111 | 0111 1111 |
| +3/4FSR | 1110 0000 | 0110 0000 | 0110 0000 |
| +1/2FSR | 1100 0000 | 0100 0000 | 0100 0000 |
| +1/4FSR | 1010 0000 | 0010 0000 | 0010 0000 |
| +0 | 1000 0000 | 0000 0000 | 0000 0000 |
| -0 | — ... — | 1111 1111 | — ... — |
| -1/4FSR | 0110 0000 | 1101 1111 | 1110 0000 |
| -1/2FSR | 0100 0000 | 1011 1111 | 1100 0000 |
| -3/4FSR | 0010 0000 | 1001 1111 | 1010 0000 |
| -FSR + 1LSB | 0000 0001 | 1000 0000 | 1000 0001 |
| -FSR | 0000 0000 | — ... — | 1000 0000 |

Signal-to-Noise Plus Distortion (SINAD)

SINAD is the ratio of the fundamental input frequency's RMS amplitude to all other ADC output signals.

$$\text{SINAD (dB)} = 20 \cdot \log \left[\frac{\text{Signal}_{\text{RMS}}}{(\text{Noise} + \text{Distortion})_{\text{RMS}}} \right]$$

Effective Number of Bits (ENOB)

ENOB indicates the global accuracy of an ADC at a specific input frequency and sampling rate. An ideal ADC's error consists only of quantization noise. With an input range equal to the full-scale range of the ADC, the effective number of bits can be calculated as follows:

$$\text{ENOB} = (\text{SINAD} - 1.76) / 6.02$$

Total Harmonic Distortion (THD)

THD is the ratio of the RMS sum of the first nine harmonics of the input signal to the fundamental itself. This is expressed as:

$$\text{THD} = 20 \cdot \log \left[\frac{\sqrt{(V_2^2 + V_3^2 + V_4^2 + \dots + V_9^2)}}{V_1} \right]$$

where V_1 is the fundamental amplitude, and V_2 through V_9 are the amplitudes of the 2nd through 9th-order harmonics.

Spurious-Free Dynamic Range (SFDR)

SFDR is the ratio of RMS amplitude of the fundamental (maximum signal component) to the RMS value of the next largest spurious component, excluding DC offset.

Grounding and Power-Supply Decoupling

Grounding and power-supply decoupling strongly influence the performance of the MAX1201. At 14-bit resolution, unwanted digital crosstalk may couple through the input, reference, power supply, and ground connections; this adversely affects the signal-to-noise ratio or spurious-free dynamic range. In addition, electromagnetic interference (EMI) can either couple into or be generated by the MAX1201. Therefore, grounding and power-supply decoupling guidelines should be closely followed.

First, a multilayer, printed circuit board (PCB) with separate ground and power-supply planes is recommended. Run high-speed signal traces on lines directly above the ground plane. Since the MAX1201 has separate analog and digital ground buses (AGND and DGND, respectively), the PCB should also have separate analog and digital ground sections connected at only one point (star ground). Digital signals should run above the digital ground plane and analog signals should run above the analog ground plane. Digital signals should be kept far away from the sensitive analog inputs, reference input senses, common-mode input, and clock input.

+5V Single-Supply, 2.2Msps, 14-Bit Self-Calibrating ADC

The MAX1201 has three power-supply inputs: analog V_{DD} (AV_{DD}), digital V_{DD} (DV_{DD}), and drive V_{DD} (DRV_{DD}). Each AV_{DD} input should be decoupled with parallel ceramic chip capacitors of values 0.1 μ F and 0.001 μ F, with these capacitors as close to the pin as possible and with the shortest possible connection to the ground plane. The DV_{DD} pins should also have separate 0.1 μ F capacitors again adjacent to their respective pins, as should the DRV_{DD} pin. Minimize the digital load capacitance. However, if the total load capacitance on each digital output exceeds 20pF, the DRV_{DD} decoupling capacitor should be increased or, preferably, digital buffers should be added.

The power-supply voltages should also be decoupled with large tantalum or electrolytic capacitors at the point the voltages enter the PCB. Ferrite beads with additional decoupling capacitors forming a pi network could also improve performance.

The analog power-supply input (AV_{DD}) for the MAX1201 is typically +5V, while the digital supplies can vary from +5V to +3V. Usually, DV_{DD} and DRV_{DD}

pins are connected to the same power supply. Note that the DV_{DD} supply voltage must be greater than or equal to the DRV_{DD} voltage. For example, a digital +3.3V supply could be connected to DRV_{DD} while a cleaner +5V supply is connected to DV_{DD} resulting in slightly improved performance. Alternatively, the +3.3V supply could be connected to both DRV_{DD} and DV_{DD} . However, the +3.3V supply should **not** be connected to DV_{DD} while the +5V supply is connected to DRV_{DD} (Table 2).

Table 2. Power-Supply-Voltage Combinations

| AVDD (V) | DVDD (V) | DRVDD (V) | ALLOWED/ NOT ALLOWED |
|----------|----------|-----------|----------------------|
| 5 | 5 | 5 | Allowed |
| 5 | 5 | 3.3 | Allowed |
| 5 | 3.3 | 3.3 | Allowed |
| 5 | 3.3 | 5 | Not Allowed |

Chip Information

TRANSISTOR COUNT: 56,577

SUBSTRATE CONNECTED TO AGND

+5V Single-Supply, 2.2Msps, 14-Bit Self-Calibrating ADC

MAX1201

Package Information

| DIM | MILLIMETERS | | INCHES | |
|-----|-------------|--------|--------|-------|
| | MIN | MAX | MIN | MAX |
| A | 2.032 | 2.388 | 0.080 | 0.094 |
| A1 | 0.102 | 0.254 | 0.004 | 0.010 |
| A2 | 1.930 | 2.134 | 0.076 | 0.084 |
| b | 0.305 | 0.457 | 0.012 | 0.018 |
| c | 0.102 | 0.254 | 0.004 | 0.010 |
| D | 12.954 | 13.462 | 0.510 | 0.530 |
| D1 | 9.906 | 10.109 | 0.390 | 0.398 |
| D3 | 8.000 | REF | 0.315 | REF |
| E | 12.954 | 13.462 | 0.510 | 0.530 |
| E1 | 9.906 | 10.109 | 0.390 | 0.398 |
| E3 | 8.000 | REF | 0.315 | REF |
| e | 0.800 | REF | 0.0315 | REF |
| L | 0.635 | 0.940 | 0.025 | 0.037 |
| α | *0 | *10 | *0 | *10 |

SEE DETAIL "A"

DETAIL "A"

NOTES:

1. D1&E1 DO NOT INCLUDE MOLD FLASH.
2. MOLD FLASH OR PROTRUSIONS NOT TO EXCEED .254mm(.010").
3. CONTROLLING DIMENSION: MILLIMETER.
4. MEETS JEDEC MO-108-AA-2.

MAXIM
 PROPRIETARY INFORMATION
 TITLE: PACKAGE OUTLINE, MQFP, 44L
 APPROVAL: DOCUMENT CONTROL NO. 21-0826 REV. C 1/1

MOFP44.EPS

*+5V Single-Supply, 2.2Msps, 14-Bit
Self-Calibrating ADC*

NOTES

MAX1201

+5V Single-Supply, 2.2Msps, 14-Bit Self Calibrating ADC

NOTES

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